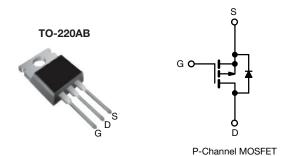


# **Power MOSFET**



PRODUCT SUMMAI	RY	
V <sub>DS</sub> (V)	-20	00
$R_{DS(on)}(\Omega)$	$V_{GS} = -10 \text{ V}$	3.0
Q <sub>g</sub> max. (nC)	1	1
Q <sub>gs</sub> (nC)	7.	0
Q <sub>gd</sub> (nC)	4.	0
Configuration	Sin	gle

#### **FEATURES**

- Dynamic dV/dt rating
- P-channel
- · Fast switching
- · Ease of paralleling
- Simple drive requirements
- Material categorization: for definitions of compliance please see <a href="https://www.vishav.com/doc?99912">www.vishav.com/doc?99912</a>

#### Note

\* This datasheet provides information about parts that are RoHS-compliant and / or parts that are non RoHS-compliant. For example, parts with lead (Pb) terminations are not RoHS-compliant. Please see the information / tables in this datasheet for details

## **DESCRIPTION**

The power MOSFETs technology is the key to Vishay's advanced line of Power MOSFET transistors. The efficient geometry and unique processing of the Power MOSFETs design achieve very low on-state resistance combined with high transconductance and extreme device ruggedness.

The TO-220AB package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 W. The low thermal resistance and low package cost of the TO-220AB contribute to its wide acceptance throughout the industry.

ORDERING INFORMATION	
Package	TO-220AB
Lead (Pb)-free	IRF9610PbF
Lead (Pb)-free and halogen-free	IRF9610PbF-BE3

ABSOLUTE MAXIMUM RATINGS ( $T_C$	= 25 °C, unles	s otherwise	e noted)			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-source voltage			V <sub>DS</sub>	-200	V	
Gate-source voltage		V <sub>GS</sub>	± 20	V		
Continuous drain current	$T_{\rm C} = 2$			-1.8		
Continuous drain current	V <sub>GS</sub> at 10 V	$T_C = 25 \degree C$ $T_C = 100 \degree C$	I <sub>D</sub>	-1.0	Α	
Pulsed drain current <sup>a</sup>			I <sub>DM</sub>	-7.0		
Linear derating factor				0.16	W/°C	
Single pulse avalanche energy b			P <sub>D</sub>	20	W	
Repetitive avalanche current a			I <sub>LM</sub>	I <sub>LM</sub> -7.0		
Repetitive avalanche energy <sup>a</sup>			dV/dt	-5.0	V/ns	
Maximum power dissipation $T_C = 25  ^{\circ}C$		T <sub>J</sub> , T <sub>stg</sub>	-55 to +150	°C		
Peak diode recovery dV/dt <sup>c</sup>						300
Operating junction and storage temperature range				10	lbf ⋅ in	
Soldering recommendations (peak temperature) d	For 10	) s		1.1		

## Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 5)
- b. Not applicable
- c.  $I_{SD} \leq$  -1.8 A, dl/dt  $\leq$  70 A/µs,  $V_{DD} \leq V_{DS},\, T_{J} \leq$  150 °C
- d. 1.6 mm from case



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THERMAL RESISTANCE RAT	INGS			
PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum junction-to-ambient	R <sub>thJA</sub>	-	62	
Case-to-sink, flat, greased surface	R <sub>thCS</sub>	0.50	-	°C/W
Maximum junction-to-case (drain)	R <sub>thJC</sub>	-	6.4	

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static							
Drain-source breakdown voltage	$V_{DS}$	V <sub>GS</sub> =	0 V, I <sub>D</sub> = -250 μA	-200	-	-	V
V <sub>DS</sub> temperature coefficient	$\Delta V_{DS}/T_{J}$	Reference	e to 25 °C, I <sub>D</sub> = -1 mA	-	-0.23	-	V/°C
Gate-source threshold voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =	V <sub>GS</sub> , I <sub>D</sub> = -250 μA	-2.0	-	-4.0	V
Gate-source leakage	I <sub>GSS</sub>	\	$I_{GS} = \pm 20 \text{ V}$	-	-	± 100	nA
	,	V <sub>DS</sub> = -200 V, V <sub>GS</sub> = 0 V		-	-	-100	
Zero gate voltage drain current	I <sub>DSS</sub>	V <sub>DS</sub> = -160 V	', V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C	-	-	-500	μΑ
Drain-source on-state resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = -10 V	I <sub>D</sub> = -0.90 A <sup>b</sup>	-	-	3.0	Ω
Forward transconductance	9 <sub>fs</sub>	V <sub>DS</sub> = -	50 V, I <sub>D</sub> = -0.90 A <sup>b</sup>	0.90	-	_	S
Dynamic							
Input capacitance	C <sub>iss</sub>	$V_{GS} = 0 \text{ V}$		-	170	-	pF
Output capacitance	C <sub>oss</sub>		$V_{DS} = -25 \text{ V},$		50	-	
Reverse transfer capacitance	C <sub>rss</sub>	f = 1.0 MHz, see fig. 10		-	15	-	
Total gate charge	Qg			-	-	11	
Gate-source charge	$Q_{gs}$	V <sub>GS</sub> = -10 V	$I_D = -3.5 \text{ A}, V_{DS} = -160 \text{ V},$ see fig. 11 and 18 b	-	-	7.0	nC
Gate-drain charge	$Q_{gd}$			-	-	4.0	
Turn-on delay time	t <sub>d(on)</sub>			-	8.0	-	
Rise time	t <sub>r</sub>	$V_{DD}$ = -100 V, $I_D$ = -0.90 A, $R_g$ = 50 $\Omega$ , $R_D$ = 110 $\Omega$ , see fig. 17 $^b$		-	15	-	ns
Turn-off delay time	t <sub>d(off)</sub>			-	10	-	
Fall time	t <sub>f</sub>			-	8.0	-	
Gate input resistance	$R_g$	f = 1 MHz, open drain		2.5	-	14.3	Ω
Internal drain inductance	L <sub>D</sub>	6 mm (0.25"	Between lead, 6 mm (0.25") from		4.5	-	nH
Internal source inductance	L <sub>S</sub>	package and center of die contact		-	7.5	-	1111
<b>Drain-Source Body Diode Characteristic</b>	es						
Continuous source-drain diode current	I <sub>S</sub>	showing the	MOSFET symbol showing the		-	-1.8	Α
Pulsed diode forward current <sup>a</sup>	I <sub>SM</sub>	integral reverse p - n junction diode		-	-	-7.0	
Body diode voltage	V <sub>SD</sub>	T <sub>J</sub> = 25 °C,	$T_J = 25  ^{\circ}\text{C},  I_S = -1.8  \text{A},  V_{GS} = 0  \text{V}^{ \text{b}}$		-	-5.8	V
Body diode reverse recovery time	t <sub>rr</sub>	T <sub>J</sub> = 25 °C, I <sub>F</sub> = -1.8 A, dI/dt = 100 A/μs b		-	240	360	ns
Body diode reverse recovery charge	Q <sub>rr</sub>			-	1.7	2.6	μC
Forward turn-on time	t <sub>on</sub>	Intrinsic turn-on time is negligible (turn-on is dominated by L <sub>S</sub> and L				L <sub>D</sub> )	

## Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 5)
- b. Pulse width  $\leq$  300 µs; duty cycle  $\leq$  2 %



## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

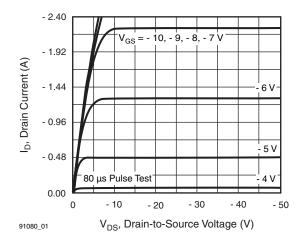


Fig. 1 - Typical Output Characteristics

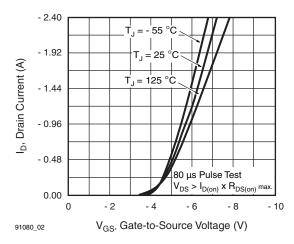


Fig. 2 - Typical Transfer Characteristics

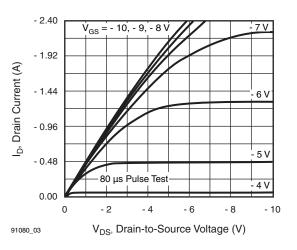


Fig. 3 - Typical Saturation Characteristics

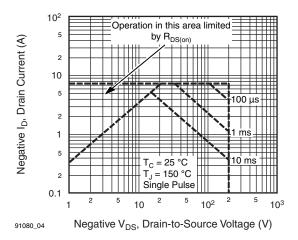


Fig. 4 - Maximum Safe Operating Area

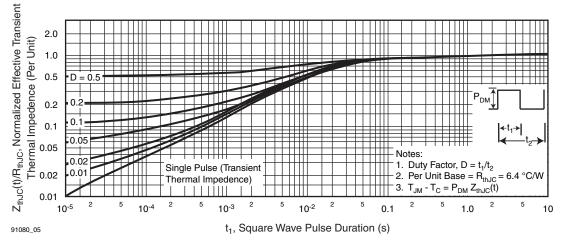


Fig. 5 - Maximum Effective Transient Thermal Impedance, Junction-to-Case vs. Pulse Duration



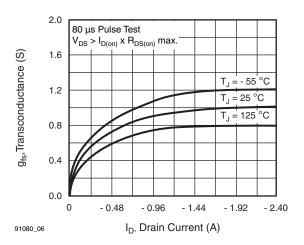


Fig. 6 - Typical Transconductance vs. Drain Current

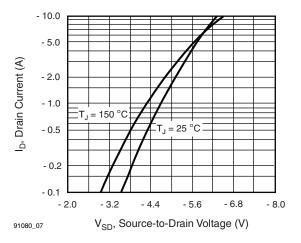


Fig. 7 - Typical Source-Drain Diode Forward Voltage

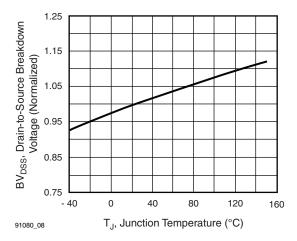


Fig. 8 - Breakdown Voltage vs. Temperature

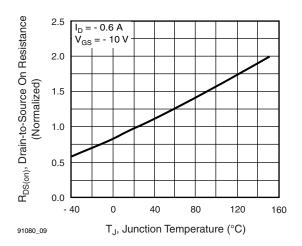


Fig. 9 - Normalized On-Resistance vs. Temperature

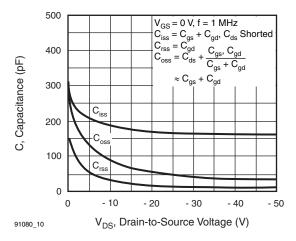


Fig. 10 - Typical Capacitance vs. Drain-to-Source Voltage

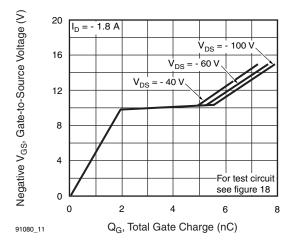


Fig. 11 - Typical Gate Charge vs. Gate-to-Source Voltage

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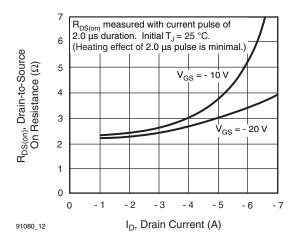


Fig. 12 - Typical On-Resistance vs. Drain Current

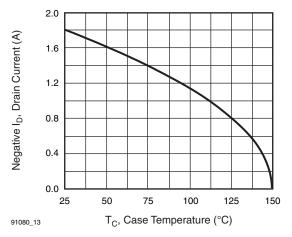


Fig. 13 - Maximum Drain Current vs. Case Temperature

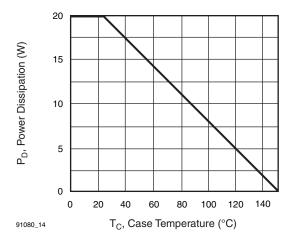


Fig. 14 - Power vs. Temperature Derating Curve

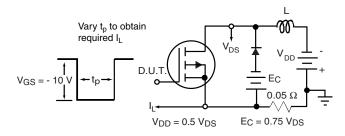


Fig. 15 - Clamped Inductive Test Circuit

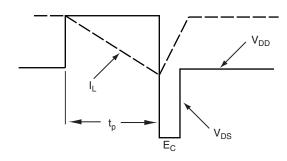


Fig. 16 - Clamped Inductive Waveforms

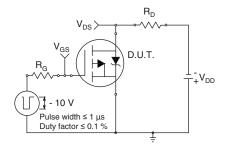


Fig. 17a - Switching Time Test Circuit

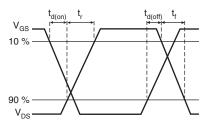


Fig. 17b - Switching Time Waveforms



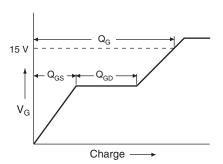


Fig. 18a - Basic Gate Charge Waveform

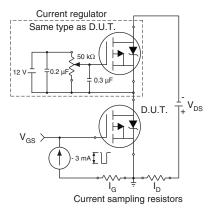
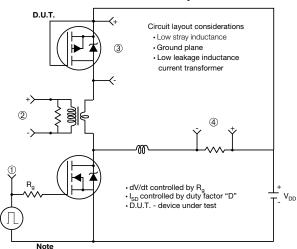


Fig. 18b - Gate Charge Test Circuit

## Peak Diode Recovery dV/dt Test Circuit



Compliment N-Channel of D.U.T. for driver

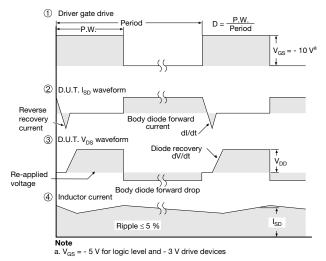


Fig. 19 - For P-Channel

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# TO-220-1



DIM.	MILLIM	IETERS	INCHES	
	MIN.	MAX.	MIN.	MAX.
Α	4.24	4.65	0.167	0.183
b	0.69	1.02	0.027	0.040
b(1)	1.14	1.78	0.045	0.070
С	0.36	0.61	0.014	0.024
D	14.33	15.85	0.564	0.624
Е	9.96	10.52	0.392	0.414
е	2.41	2.67	0.095	0.105
e(1)	4.88	5.28	0.192	0.208
F	1.14	1.40	0.045	0.055
H(1)	6.10	6.71	0.240	0.264
J(1)	2.41	2.92	0.095	0.115
L	13.36	14.40	0.526	0.567
L(1)	3.33	4.04	0.131	0.159
ØΡ	3.53	3.94	0.139	0.155
Q	2.54	3.00	0.100	0.118

## Note

DWG: 6031

•  $M^* = 0.052$  inches to 0.064 inches (dimension including protrusion), heatsink hole for HVM



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